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A cubic calcium oxynitrido-silicate, $Ca_{2.89}Si_2N_{1.76}O_{4.24}$

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Key indicators: single-crystal X-ray study; T = 293 K; mean σ (Si–O) = 0.002 Å; disorder in main residue; R factor = 0.032; wR factor = 0.069; data-to-parameter ratio = 17.5.

The title compound, tricalcium oxynitride silicate, with composition $Ca_{3-x}Si_2N_{2-2x}O_{4+2x}$ ($x \simeq 0.12$), is a perovskiterelated calcium oxynitrido silicate containing isolated oxynitrido silicate 12-rings. The N atoms are statistically disordered with O atoms (occupancy ratio N:O = 0.88:0.12) and occupy the bridging positions in the 12 ring oxynitrido silicate anion, while the remaining O atoms are located at the terminal positions of the Si(O,N)₄ tetrahedra. The majority of the Ca²⁺ cations fill the channels along [100] in the packing of the 12ring anions. The rest of these cations are located at several positions, with partial occupancy, in channels along the body diagonals.

Related literature

For a closely related silicate, as well as a germanate, see: Fischer & Tillmanns (1984) and for a more distantly related calcium aluminate, see: Mondal & Jeffery (1975)

Experimental

Crystal data Ca_{2.89}Si₂N_{1.76}O_{4.24} $M_r = 264.65$

Cubic, $Pa\overline{3}$ a = 15.0626 (1) Å V = 3417.45 (4) Å³ Z = 24Mo *K* α radiation

Data collection

Oxford Diffraction XcaliburIII with
Sapphire-3 CCD diffractometer
Absorption correction: multi-scan
(CrysAlis RED; Oxford
Diffraction, 2008)
$T_{\min} = 0.67, \ T_{\max} = 0.94$

Refinement

$$\begin{split} R[F^2 > 2\sigma(F^2)] &= 0.032 & 113 \text{ parameters} \\ wR(F^2) &= 0.069 & \Delta\rho_{\text{max}} &= 0.87 \text{ e} \text{ Å}^{-3} \\ S &= 1.22 & \Delta\rho_{\text{min}} &= -0.76 \text{ e} \text{ Å}^{-3} \\ 1982 \text{ reflections} & \end{split}$$

Table 1			
Selected	bond	lengths	(Å).

1.6245 (15) 1.6341 (15) Si1 - O4Si2 - O6Si1-O3 1.6476 (14) Si2-O51.6485 (15) Si1-N2/O2 1.6788 (18) Si2-N1/O1i 1.6899 (17) Si1-N1/O1 1.6958 (17) Si2-N2/O2 1.6942 (18)

 $\mu = 3.18 \text{ mm}^{-1}$

 $0.10 \times 0.06 \times 0.02 \text{ mm}$

30793 measured reflections 1982 independent reflections

1779 reflections with I > 2s(I)

T = 293 K

 $R_{\rm int} = 0.027$

Symmetry code: (i) $-y + \frac{1}{2}, z - \frac{1}{2}, x + 1$.

Data collection: *CrysAlis CCD* (Oxford Diffraction, 2008); cell refinement: *CrysAlis RED* (Oxford Diffraction, 2008); data reduction: *CrysAlis RED*; program(s) used to solve structure: *SHELXS97* (Sheldrick, 2008); program(s) used to refine structure: *SHELXL97* (Sheldrick, 2008); molecular graphics: *DIAMOND* (Brandenburg, 2001); software used to prepare material for publication: *PLATON* (Spek, 2009) and *SHELXL97*.

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Supplementary data and figures for this paper are available from the IUCr electronic archives (Reference: FJ2455).

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supplementary materials

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A cubic calcium oxynitrido-silicate, Ca_{2.89}Si₂N_{1.76}O_{4.24}

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Comment

The title compound is a crystalline component formed in the melts of oxynitrido glasses, studied at our department. The title compound calcium oxynitrido-silicate contains isolated 12-ring anions with the ideal composition $Ca_{3-x}Si_2N_{2-2x}O_4 + 2x$ where the title compound have $x \approx 0.12$. It should be emphasized that x=0 do not indicate an end member of a possible solid solution series of compounds. The nitrogen atoms in the anions occupies mainly the ring positions in the 12 ring while the oxygen atoms mainly occupy the apex positions. A figure of the oxynitrido-silicate anion is shown in Fig. 1. In Fig. 2 a simplified packing is shown where the arrangement of Ca atoims in channels along <100> as well as the disordered arrangement along the <111> directions. 56 Ca atoms in each unit cell fills channels along <100> in the packing of the 12-ring anions while the rest of the Ca positions are located in channels along <111> and show tendencies to be disordered. The split positions of the Ca cations along the <111> can be viewed as a consequence of the implied Pa-3 symmetry. Whether the space group should better be $P2_13$ or even $P2_12_12_1$ with cubic twinning is unfortunately not possible to determine, neither from systematic reflection conditions nor from investigations of the s.u. of the cell parameters. No One can refine orthorhombic unit-cell parameters but if one should believe the e.s.d.'s is more of an open question. We choose to describe the structure with highest possible symmetry but at the price of some disorder. Similar arrangements of cations and ring formed anions are found in the structurally related compounds K₄SrGe₃O₉ and Na₄CaSi₃O₉ (Fischer & Tillmanns, 1984).

Experimental

The title compound was obtained by slow cooling of a melt with the nominal composition $Ca_{1.71}Si_2O_{1.71}N_{2.67}$ from 1700° C by 1° C / min in a graphite furnace.

Refinement

In order to match the refined Ca composition the N1 and N2 position were mixed occupied by 88° N and 12°O. Attempts to refine the N/O ratio from the X-ray diffraction data failed using the present single-crystal data as a consequence of the close resemblance of the atomic form factors of N and O. The occupancy factors of the Calcium ions did converge to the composition reported in the title and was fully consistent with results from EDS analyses giving the ratio Ca/Si = 0.59 (1). The refined Ca content 2.88 and 2 Si give the Ca/Si = 0.59. It must be emphasized that the precise occupation of Ca atoms are heavily dependent on the precise model used. Including a larger number of Ca atoms, one could refine the model slightly closer to the ideal composition Ca₃Si₂O₄N₂.

Figures

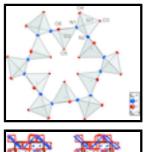


Fig. 1. The oxynitrido-silicate anion of the title compound (I) with the unique atoms of the oxynitrido-silicate anion labelled. Displacement ellipsoids drawn at 50% probability.

Fig. 2. Stereoview of the unitcell viewed approximately along [100] with the oxynitrido-silicate anions marked with red colour and the Ca atoms ffwith blue colour. The disordered arrays of Ca atoms along the <111> shown by a solid rod.

tricalcium oxynitride silicate

Crystal data

Ca _{2.89} Si ₂ N _{1.76} O _{4.24}	$D_{\rm x} = 3.087 {\rm ~Mg} {\rm ~m}^{-3}$
$M_r = 264.65$	Mo K α radiation, $\lambda = 0.71073$ Å
Cubic, $Pa\overline{3}$	Cell parameters from 19622 reflections
Hall symbol: -P 2ac 2ab 3	$\theta = 3.8 - 32.2^{\circ}$
a = 15.0626 (1) Å	$\mu = 3.18 \text{ mm}^{-1}$
$V = 3417.45 (4) \text{ Å}^3$	T = 293 K
Z = 24	Block, colourless
F(000) = 3158	$0.10\times0.06\times0.02~mm$

Data collection

Oxford Diffraction XcaliburIII with Sapphire-3 CCD diffractometer	1982 independent reflections
Radiation source: fine-focus sealed tube	1779 reflections with $I > 2s(I)$
graphite	$R_{\rm int} = 0.027$
Detector resolution: 16.5467 pixels mm ⁻¹	$\theta_{\text{max}} = 32.3^{\circ}, \ \theta_{\text{min}} = 3.8^{\circ}$
ω scans at different φ	$h = -22 \rightarrow 18$
Absorption correction: multi-scan (<i>CrysAlis RED</i> ; Oxford Diffraction, 2008)	$k = -18 \rightarrow 21$
$T_{\min} = 0.67, \ T_{\max} = 0.94$	$l = -22 \rightarrow 21$
30793 measured reflections	

Refinement

Refinement on F^2	Primary atom site location: structure-invariant direct methods
Least-squares matrix: full	Secondary atom site location: difference Fourier map
$R[F^2 > 2\sigma(F^2)] = 0.032$	$w = 1/[\sigma^2(F_0^2) + (0.026P)^2 + 5.7834P]$ where $P = (F_0^2 + 2F_c^2)/3$

$wR(F^2) = 0.069$	$(\Delta/\sigma)_{\rm max} = 0.001$
<i>S</i> = 1.22	$\Delta \rho_{max} = 0.87 \text{ e } \text{\AA}^{-3}$
1982 reflections	$\Delta \rho_{min} = -0.76 \text{ e } \text{\AA}^{-3}$
113 parameters	Extinction correction: <i>SHELXL97</i> (Sheldrick, 2008), $Fc^*=kFc[1+0.001xFc^2\lambda^3/sin(2\theta)]^{-1/4}$
0 restraints	Extinction coefficient: 0.00048 (5)

Special details

Geometry. All e.s.d.'s (except the e.s.d. in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell e.s.d.'s are taken into account individually in the estimation of e.s.d.'s in distances, angles and torsion angles; correlations between e.s.d.'s in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell e.s.d.'s is used for estimating e.s.d.'s involving l.s. planes.

Refinement. Refinement of F^2 against ALL reflections. The weighted *R*-factor *wR* and goodness of fit *S* are based on F^2 , conventional *R*-factors *R* are based on *F*, with *F* set to zero for negative F^2 . The threshold expression of $F^2 > \sigma(F^2)$ is used only for calculating *R*-factors(gt) *etc.* and is not relevant to the choice of reflections for refinement. *R*-factors based on F^2 are statistically about twice as large as those based on *F*, and *R*- factors based on ALL data will be even larger.

Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters (A^2)

	x	у	Ζ	$U_{\rm iso}$ */ $U_{\rm eq}$	Occ. (<1)
Si1	0.00530 (3)	0.27221 (3)	0.76315 (3)	0.00633 (9)	
Si2	0.01658 (3)	0.24358 (3)	0.98439 (3)	0.00567 (9)	
N1	0.01861 (12)	0.37791 (11)	0.72676 (13)	0.0176 (3)	0.88
01	0.01861 (12)	0.37791 (11)	0.72676 (13)	0.0176 (3)	0.12
N2	0.00891 (13)	0.26556 (13)	0.87435 (11)	0.0193 (4)	0.88
O2	0.00891 (13)	0.26556 (13)	0.87435 (11)	0.0193 (4)	0.12
O3	0.09048 (10)	0.21494 (9)	0.72534 (9)	0.0131 (3)	
04	-0.09065 (10)	0.23612 (10)	0.72964 (10)	0.0160 (3)	
05	-0.01845 (10)	0.33802 (10)	1.02719 (10)	0.0147 (3)	
O6	-0.04423 (10)	0.15759 (10)	1.01040 (10)	0.0153 (3)	
Cal	-0.12893 (2)	0.37107 (2)	1.12893 (2)	0.01028 (12)	
Ca2	-0.11371 (3)	0.38333 (3)	0.90382 (3)	0.01162 (8)	
Ca3	0.13964 (3)	0.13071 (3)	0.85405 (3)	0.01601 (9)	
Ca4	0.24330 (14)	0.25670 (14)	0.74330 (14)	0.0094 (6)*	0.1715 (6)
Ca5	0.1757 (2)	0.3243 (2)	0.6757 (2)	0.0094 (2)*	0.140 (2)
Ca6	0.15523 (5)	0.34477 (5)	0.65523 (5)	0.0094 (2)*	0.670 (3)
Ca7	0.1254 (9)	0.3746 (9)	0.6254 (9)	0.0094 (2)*	0.043 (3)
Ca8	0.1031 (7)	0.3969 (7)	0.6031 (7)	0.0094 (2)*	0.076 (2)
Ca9	0.0819 (5)	0.4181 (5)	0.5819 (5)	0.0094 (2)*	0.086 (3)
Ca10	0.0572 (3)	0.4428 (3)	0.5572 (3)	0.0094 (2)*	0.099 (2)
Ca11	0.0166 (4)	0.4834 (4)	0.5166 (4)	0.0094 (2)*	0.095 (3)
Ca12	0.0000	0.5000	0.5000	0.0094 (2)*	0.603 (6)
, . . .		,			
Atomic displac	cement parameters (A^2))			
	U^{11} U	U^{33} U^{33}	U^{12}	U^{13}	U^{23}

supplementary materials

Si1	0.0077 (2)	0.0061 (2)	0.0052 (2)	-0.00013 (16)	-0.00028 (15)	-0.00047 (15)
Si2	0.00564 (19)	0.0064 (2)	0.0049 (2)	0.00030 (16)	0.00068 (15)	-0.00020 (16)
N1	0.0206 (8)	0.0063 (7)	0.0260 (9)	0.0011 (6)	0.0043 (7)	0.0004 (6)
01	0.0206 (8)	0.0063 (7)	0.0260 (9)	0.0011 (6)	0.0043 (7)	0.0004 (6)
N2	0.0240 (9)	0.0274 (9)	0.0066 (7)	-0.0007 (7)	0.0010 (6)	-0.0004 (6)
O2	0.0240 (9)	0.0274 (9)	0.0066 (7)	-0.0007 (7)	0.0010 (6)	-0.0004 (6)
O3	0.0149 (6)	0.0105 (6)	0.0140 (6)	0.0035 (5)	0.0042 (5)	-0.0008 (5)
O4	0.0150 (6)	0.0162 (7)	0.0169 (7)	-0.0055 (5)	-0.0065 (5)	0.0014 (5)
05	0.0174 (7)	0.0124 (6)	0.0144 (6)	0.0057 (5)	-0.0035 (5)	-0.0062 (5)
O6	0.0157 (7)	0.0132 (6)	0.0170 (7)	-0.0063 (5)	0.0040 (5)	0.0008 (5)
Cal	0.01028 (12)	0.01028 (12)	0.01028 (12)	-0.00048 (12)	0.00048 (12)	0.00048 (12)
Ca2	0.01262 (17)	0.00917 (16)	0.01306 (17)	0.00006 (12)	-0.00140 (13)	0.00004 (12)
Ca3	0.01781 (19)	0.01586 (19)	0.01435 (18)	0.00563 (14)	-0.00307 (14)	-0.00105 (14)

Geometric parameters (Å, °)

Si1—O4	1.6245 (15)	Si2—O6	1.6341 (15)
Si1—O3	1.6476 (14)	Si2—O5	1.6485 (15)
Si1—N2	1.6788 (18)	Si2—N1 ⁱ	1.6899 (17)
Si1—N1	1.6958 (17)	Si2—N2	1.6942 (18)
O4—Si1—O3	114.22 (8)	O6—Si2—N1 ⁱ	109.58 (9)
O4—Si1—N2	108.60 (9)	O5—Si2—N1 ⁱ	108.13 (9)
O3—Si1—N2	106.76 (9)	O6—Si2—N2	110.56 (9)
O4—Si1—N1	108.59 (9)	O5—Si2—N2	101.08 (9)
O3—Si1—N1	106.72 (8)	O1 ⁱ —Si2—N2	113.07 (9)
N2—Si1—N1	112.00 (10)	N1 ⁱ —Si2—N2	113.07 (9)
O6—Si2—O5	114.26 (8)	Si2 ⁱⁱ —N1—Si1	142.98 (12)
O6—Si2—O1 ⁱ	109.58 (9)	Si1—N2—Si2	171.87 (14)
$O5$ —Si2— $O1^i$	108.13 (9)		

Symmetry codes: (i) -y+1/2, z-1/2, x+1; (ii) z-1, -x+1/2, y+1/2.

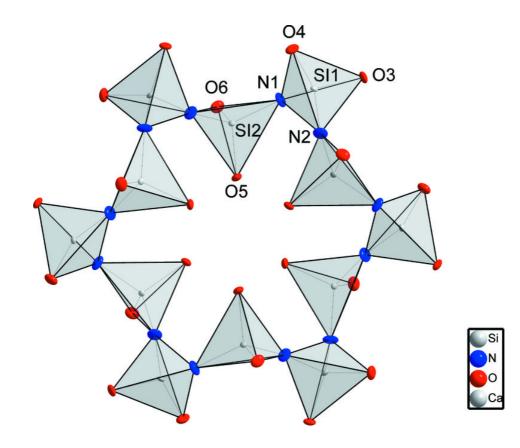


Fig. 1

Fig. 2

